Search Notes

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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,085	LEE ET AL.	
Examiner	Art Unit	
Juan A. Torres	2611	

SEARCHED					
Class	Subclass	Date	Examiner		
375	346, 130, 147	11/15/2006	JATM		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	11/15/2006	JATM		
IDS Flag Clearance	11/15/2006	JATM		
Inventor search	11/15/2006	JATM		
Claim interference search	11/15/2006	JATM		
Google	11/15/2006	JATM		
Scirus	11/15/2006	JATM		
IEEE	11/15/2006	JATM		